Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/765,164	TSUDA ET AL.
Examiner	Art Unit
Michael A. Friedhofer	2832

	SEARCHED				
Class	Subclass	Date	Examiner		
200	16r- 16d,553, 557- 559,561- 563	8/23/2005	MAF		
200	339,276.1	8/23/2005	MAF		
200	61.82,534	8/23/2005	MAF		
200	537	8/23/2005	MAF		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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